

#### **Power Supply Design Seminar**

Topic 1 Presentation:

## Under the Hood of Flyback SMPS Designs

Reproduced from 2010 Texas Instruments Power Supply Design Seminar SEM1900, Topic 1 TI Literature Number: SLUP254

© 2010, 2011 Texas Instruments Incorporated

Power Seminar topics and online powertraining modules are available at: power.ti.com/seminars



Topic 1

# Under the Hood of Flyback SMPS Designs

**Jean Picard** 



SLUP254

# Agenda

- 1. Basics of Flyback Topology
- 2. Impact of Transformer Design on Power Supply Performance
- 3. Power Supply Current Limiting
- 4. Summary

- FET turns ON
  - Voltage across primary magnetizing inductance ≅ V<sub>i</sub>
    - Energy is stored in flyback transformer: Function of L, D and T<sub>s</sub>
  - Secondary diode in blocking state
- FET turns OFF
  - During commutation: Leakage energy absorbed by clamp circuit
  - Stored energy transferred to output through diode
  - If DCM operation, all the stored energy is transferred
- Pulsating input <u>and</u> output current



- FET turns ON
  - Voltage across primary magnetizing inductance  $\cong V_i$ 
    - Energy is stored in flyback transformer: Function of L, D and T<sub>s</sub>
  - Secondary diode in blocking state
- FET turns OFF
  - During commutation: Leakage energy absorbed by clamp circuit
  - Stored energy transferred to output through diode
  - If DCM operation, all the stored energy is transferred
- Pulsating input <u>and</u> output current



- FET turns ON
  - Voltage across primary magnetizing inductance  $\cong V_i$ 
    - Energy is stored in flyback transformer: Function of L, D and T<sub>s</sub>
  - Secondary diode in blocking state

#### • FET turns OFF

- During commutation: Leakage energy absorbed by clamp circuit
- Stored energy transferred to output through diode
- If DCM operation, all the stored energy is transferred
- Pulsating input <u>and</u> output current



- FET turns ON
  - Voltage across primary magnetizing inductance  $\cong V_i$ 
    - Energy is stored in flyback transformer: Function of L, D and T<sub>s</sub>
  - Secondary diode in blocking state
- FET turns OFF
  - During commutation: Leakage energy absorbed by clamp circuit
  - Stored energy transferred to output through diode
  - If DCM operation, <u>all</u> the stored energy is transferred
- Pulsating input <u>and</u> output current



# **CCM versus DCM**

- Continuous conduction mode (CCM)
  - Small ripple and rms current
  - Lower MOSFET conduction and turn-off loss
  - Lower core loss
  - Lower capacitors loss
  - Can have better "full load" efficiency
  - Smaller EMI and output filters
- Discontinuous conduction mode (DCM)
  - No diode reverse recovery loss
  - Lower inductance value
    - May result in a smaller transformer
  - Better "no load" efficiency
  - First-order system
    - Inherently stable
  - No RHPZ problem
  - Slope compensation not needed in CMC





SLUP254

## **Right-Half-Plane Zero, CCM Operation**

- Energy is delivered during 1 D
  - Effect of control action during ON time is delayed until next switch turn OFF
- Initial reaction is in opposite direction of desired correction
- $\Rightarrow$  RHP Zero
  - Phase decreases with increasing gain





# **RCD Clamp Circuit**

- During commutation primary-tosecondary, the leakage energy is absorbed by the clamp circuit
  - R<sub>clamp</sub> dissipates the leakage energy and some magnetizing energy
  - The clamp capacitor ensures a low voltage ripple
  - Use short connection with minimum loop area
- V<sub>clamp</sub> is maximum at full load and minimum input voltage
  - R<sub>clamp</sub> selected for a maximum drain voltage in worst case
  - Tradeoff between efficiency, peak drain voltage, output current limit and cross regulation (see ringing effect)



# Agenda

1. Basics of Flyback Topology

### 2. Impact of Transformer Design on Power Supply Performance

- 3. Power Supply Current Limiting
- 4. Summary

## **Transformer's Leakage Inductance**

- Transformer's leakage inductance represented by L<sub>leak2</sub>
  - Primary winding is the closest to center gap
- When FET turns OFF
  - $L_{leak2}$  opposes to  $I_P$  decrease and  $I_S$  increase
  - Magnetizing inductance works to maintain magnetizing current
- Voltage spike on FET during commutation
- Rate of rise of current is influenced by leakage inductance
- Commutation primary-tosecondary is not instantaneous and depends on V<sub>clamp</sub>
  - Loss of volt-seconds



## **Effects of Leakage Inductance**

- Clamp circuits and snubbers needed for primary FET and secondary rectifier(s)
- Lower power-supply efficiency
- Impact on gate-drive strategy if synchronous rectifier is used
- Higher duty cycle and magnetizing current than expected
- Higher H-field radiated emission
- High impact on cross-regulation

# How Leakage Can Be Minimized

- Leakage inductance is a function of winding geometry, number of turns and separation between primary and secondary
  - Minimize the separation between the primary and main secondary winding(s)
  - Interleave the primary and main secondary
  - Select a core with a long and narrow window



#### Option 1

Option 2

- Leakage inductance is <u>not</u> lowered with a high permeability core
- Having the winding tightly coupled to the core will not reduce it

## **Cross-Regulation – Overview**

- Multiple-output flyback topology is popular because of its simplicity and low cost
- If the coupling is perfect, the turns ratio directly defines output voltages
- In the real world, "perfect" coupling is not possible
- This often results in poor cross-regulation

## **Cross-Regulation Physical Model**

- Transformer windings cannot all be equally well coupled to the gap because of physical separation between them
- Magnetic energy stored <u>between</u> the windings represented as leakage inductances
- Model not applicable to any transformer geometry
- Can become complex if interleaving is used, or if multiple secondary windings are wound simultaneously (multifilar)
- Not accurate in situation of lightly loaded secondary outputs
- Good tool to understand how the common flyback transformer geometries work

## **Cross-Regulation Physical Model**



- This circuit is only applicable to the transformer windings stackup shown
- Each leakage inductance considered is between two consecutive secondaries
- Also called "Ladder model"

### Flux Lines during Commutation Each Secondary Winding with Nominal Load

- $\phi_m$  decreases during commutation

$$e = -N \times \frac{d\phi_m}{dt}$$

- Leakage between W2 and W1
  - W1's voltage limited by clamp
- W1 closest to gap
  - $V_{\text{clamp}}$  limits  $d\varphi_{\text{m}}/dt$  in the gap during commutation
- W2 is next to W1
  - W2 limits the  $d\phi/dt$  seen by W3 and W4
  - W3 and W4 output voltage lower than without leakage
- Current commutates progressively from near to remote secondary windings







During Primary-to-Secondary Commutation Current in All Windings



Secondary Currents During Commutation Based on Physical Model

# **Ringing Effect**

- High dV/dt when main switch turns off if main output is heavily loaded
- Transformer leakage inductance and parasitic capacity ⇒ auxiliary secondary voltage tends to "ring"
- If auxiliary output fully loaded  $\Rightarrow$  this ringing is clamped
- If lightly loaded  $\Rightarrow$  voltage overshoot with peak detector effect
- Much higher (sometimes > 2 x nominal value!) auxiliary output voltage at light load
  - Primary clamp voltage has high impact on result
- Most existing transformer models fail to predict this
- This effect can be mitigated (but not eliminated)
  - Minimize leakage inductance *between secondary* windings
  - Locate the highest power secondary(ies) closest to the primary
- Other solutions include a post-regulator, series resistor or minimum load

### Cross-Regulation Example Auxiliary Output Lightly Loaded

- W2 (high current output) heavily loaded, W4 lightly loaded
  - W4's output received too much energy during Phase 1 due to ringing
  - W2's output did not receive enough energy
- At end of commutation (Phase 1):
  - Σ{reflected secondary currents} ⇔ magnetizing current
- V4 went too high
  - Phase 2: high  $d\phi/dt$  (decreasing) in W4
    - +  $I_{W4} \Rightarrow 0 A rapidly$
  - $~I_{W2}$  increases to maintain  $\varphi_m$  in the gap
- After I<sub>W4</sub> crosses 0 A, W2's and W3's di/dt change to maintain the downslope of the magnetizing current and flux

$$H \times \delta = \frac{\phi_m}{A \times \mu} \times \delta = \sum N \times I$$

Texas Instruments—2010 Power Supply Design Seminar



Phase 2: No Primary Current

## **Test Results**



- 5-V output load: 0 A to 5 A
- Auxiliary outputs: V6 (10 V at 0 to 140 mA) and V4 (18 V at 0 to 200 mA)
- Switching frequency: 250 kHz
- Primary magnetizing inductance: 70 µH

## Cross-Regulation Test Results with Main Output Fully Loaded



- The two auxiliary outputs operate in DCM
- Notice the change of slope of  $I_{\rm W2}$  when  $I_{\rm W4}$  or  $I_{\rm W6}$  crosses 0 A

#### Cross-Regulation Test Results: Lightly Loaded Auxiliary with Main Output Fully Loaded



• At minimum load, V6 (10 V nominal) goes up to 20.6 V

#### Cross-Regulation Test Results with Main Output Fully Loaded : Impact of Clamp Voltage



• RCD resistor has been increased for higher V<sub>clamp</sub>: 70 V  $\Rightarrow$  83 V

 $\Rightarrow$ V6 increased significantly in both cases

## Overload Test at Auxiliary Output: Impact of Leakage

- There was no hiccup mode even at more than 3 A!
- The overloaded winding is unable to take all the energy because of leakage, W3 having in fact a better coupling to primary than W6
  - Enough energy delivered by W3 to V<sub>DD</sub> to maintain switching



## **Benefits of Good Cross-Regulation**

- Good control of auxiliary outputs in spite of load variations
- Better control of gate drive voltage amplitude, less gate drive losses
- Lower rms current in output capacitors, lower dissipation
- May allow the controller to reach hiccup mode more easily when the main output is short-circuited for better protection
  - Not necessarily true if the short-circuit is applied to an <u>auxiliary</u> output!

## How Cross-Regulation can be Improved

- The high current winding must have the best coupling to primary
- Minimize leakage <u>between</u> all secondary windings ٠
- Optimize, not minimize, the leakage inductance of auxiliary windings to *primary*
- Use winding placement to control leakage inductance
  - Winding stackup
  - Spread each winding over the full width of the bobbin for better coupling

ш







If W3 is lightly loaded and W2 is the highcurrent main output.

- Operate main output in CCM
- Try to avoid operating the auxiliary outputs in DCM. In some cases, consider using resistance in series with the diode
- Consider winding more than one auxiliary secondary simultaneously (multifilar)
- Lower clamp voltage may help
  - Trade-off between cross regulation, efficiency, peak drain voltage and current limit
  - Some other types of clamp circuits may provide better results than the RCD clamp

#### Impact of Transformer Design on Flyback Efficiency

- The following guidelines can be used during transformer design to optimize the converter efficiency
  - Minimize leakage inductance from primary to main (high-current) secondary
  - Minimize transformer high frequency conduction loss
    - Multifilar or Litz wires when necessary
    - Interleaving
    - Select core shape for minimum number of layers
  - Optimize the transformer turns ratio for best efficiency
  - Select CCM operation
- · Other factors also have an indirect impact on efficiency
  - Cross-regulation
    - +  $V_{\text{DD}}$  rail used for gate drive
    - Output capacitors rms current
  - Impact of fringing flux from gap
    - Worse with planar transformers





## **Flyback and EMI**

- Flyback  $\Rightarrow$  I<sub>P</sub> and I<sub>S</sub> pulsate
  - Use low Z caps, minimize loop areas
  - Output filter often required
- Interwinding capacitance  $\Rightarrow$  CM CE
- Transformer and diode configuration
  impact effective capacitance
  - Less if facing windings at same AC potential
  - Diode versus synchronous rectifier
  - Flyback ≠ Forward
- Better to start with end connected to primary MOSFET
  - Shields V<sub>drain</sub> E-field
  - Reduces interwinding capacity effect on CE
- Minimize leakage for low H-field RE
- Interleaving reduces H-field RE but may increase effective P-S interwinding capacitance
- Center-gap transformer

Texas Instruments—2010 Power Supply Design Seminar





**1-28** SLUP254

# Agenda

- 1. Basics of Flyback Topology
- 2. Impact of Transformer Design on Power Supply Performance

## 3. Power Supply Current Limiting

4. Summary

# **Power Supply Current Limiting – Overview**

- Current-limiting characteristic of power supply defines:
  - Output power beyond which output voltage falls out of regulation. Corresponds to the "output load-current limit" (I<sub>out\_LIM</sub>)
  - Output current in overload situations
    - including short-circuits
- Current-limiting characteristic is influenced by parasitics
  - Turn-off delays, leakage inductance,...

### Understanding Current Limit – Flyback Power Supply with Peak CMC in CCM



### **Current-Limit Model – Basic Representation**

• Peak CMC in CCM, fixed switching frequency



Neglecting DC voltage drops:

$$m_2 = \frac{\Delta I_L}{(1-D) \times T_S} \approx \frac{V_o}{n_2 \times L}$$
 I



### Influence of Input DC Voltage on Output Load Current Limit – Impact of Feedforward



- With feedforward, output load current limit becomes almost independent of input voltage
  - $\Rightarrow$  Better control during overload, less stress on power circuitry
  - $\Rightarrow$  Power limit
  - $\Rightarrow$  Cost and/or size reduction
- · Feedforward also improves line noise rejection

### **Current Limit Model – With Feedforward**



•  $K_{ff} \times V_i$  is the feedforward contribution

– Subtracting it from  $V_{\rm c}$  is identical to adding it to current feedback

#### **Current Limit Model – Adding Slope Compensation**



- Slope compensation to avoid subharmonic oscillation at duty-cycle close to or higher than 50%
- For easier understanding, slope compensation contribution subtracted from V<sub>c</sub>.
  - Equivalent to slope compensation added to current feedback
  - In that circuit representation, the slope compensation is capacitively-coupled

### Current Limit Model – With all Delays, Slope Compensation and Feedforward

- For a more accurate, parasitics must be included in the analysis
- Parasitic delays
  - RC filter time delay
  - Turn off delay, including current comparator and gate drive
  - FET turn-on delay from onset of slope compensation ramp
- See Topic 1, Appendix A, in the Seminar Manual for detailed equations

### Influence of Transformer Leakage on Output Load Current Limit

- Rate of rise of current is influenced by leakage, commutation primary-tosecondary is not instantaneous
  - $\Rightarrow$  Loss of volt-seconds (also influenced by the clamp voltage)
  - ⇒ Duty-cycle and average magnetizing current have to increase to maintain the output voltage
  - $\Rightarrow$  Higher conduction loss
  - ⇒ Higher transformer peak current than expected

-> I<sub>out\_LIM</sub> lower than expected

 Leakage inductance helps however to keep control of the output current in output short-circuit situation



### Current Limit During Overload – Example with Combined Effects

- In overload: Output current increases ⇒ output voltage decreases
  - Short-circuit: output current much higher than at onset of current limit
- Parasitic turn off delays may result in an out of control current if volt-seconds balance is not possible at the transformer
  - Transformer's leakage inductance helps to maintain that balance
  - If no leakage, the imbalance occurs starting at  $V_{o1}$
  - With leakage, the imbalance occurs only from  $V_{o2}$



$$V_i \times t_{del_{OFF}} - V_{clamp} \times D_{tr} \times T_S$$

Texas Instruments—2010 Power Supply Design Seminar

1-38 SLUP254

# Summary

- The flyback power transformer is the key element of the converter, for optimum efficiency and cross-regulation
- Parasitics have a strong influence on flyback converter's behavior, particularly under overload or short-circuit conditions
- The primary clamp circuit design is a trade-off between:
  - Efficiency
  - Peak drain voltage
  - Output current limit
  - Cross-regulation
- Simple feedforward technique can be used to optimize the converter and the system, lowering worst-case components stress and reducing the overall cost and size

#### TI Worldwide Technical Support

#### **Internet**

TI Semiconductor Product Information Center Home Page support.ti.com

#### TI E2E<sup>™</sup> Community Home Page

e2e.ti.com

#### **Product Information Centers**

Americas	Phone	+1(972) 644-5580
Brazil	Phone	0800-891-2616
Mexico	Phone	0800-670-7544
Intern	Fax et/Email	+1(972) 927-6377 support.ti.com/sc/pic/americas.htm

#### Europe, Middle East, and Africa

Phone

European Free Call	00800-ASK-TEXAS (00800 275 83927)	
International	+49 (0) 8161 80 212	
Russian Support	+7 (4) 95 98 10 701	

**Note:** The European Free Call (Toll Free) number is not active in all countries. If you have technical difficulty calling the free call number, please use the international number above.

Fax
Internet
Direct Email

+(49) (0) 8161 80 2045 support.ti.com/sc/pic/euro.htm asktexas@ti.com Important Notice: The products and services of Texas Instruments Incorporated and its subsidiaries described herein are sold subject to TI's standard terms and conditions of sale. Customers are advised to obtain the most current and complete information about TI products and services before placing orders. TI assumes no liability for applications assistance, customer's applications or product designs, software performance, or infringement of patents. The publication of information regarding any other company's products or services does not constitute TI's approval, warranty or endorsement thereof.

Domestic

International

Domestic

Domestic

Japan

Phone

Fax

0120-92-3326

0120-81-0036

www.tij.co.jp/pic

+81-3-3344-5317

Internet/Email International

support.ti.com/sc/pic/japan.htm

#### Asia

Phone				
International		+91-80-41381665		
Domestic		Toll-Free Number		
Note: Toll-free numbers do not support mobile and IP phones.				
Australia		1-800-999-084		
China		800-820-8682		
Hong Kong		800-96-5941		
India		1-800-425-7888		
Indonesia		001-803-8861-1006		
Korea		080-551-2804		
Malaysia		1-800-80-3973		
New Zealand		0800-446-934		
Philippines		1-800-765-7404		
Singapore		800-886-1028		
Taiwan		0800-006800		
Thailand		001-800-886-0010		
Fax	+8621-2307	73686		
Email	tiasia@ti.com or ti-china@ti.com			
Internet support.ti.com/sc/pic/as		m/sc/pic/asia.htm		
		A122010		



#### **IMPORTANT NOTICE**

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

TI products are not authorized for use in safety-critical applications (such as life support) where a failure of the TI product would reasonably be expected to cause severe personal injury or death, unless officers of the parties have executed an agreement specifically governing such use. Buyers represent that they have all necessary expertise in the safety and regulatory ramifications of their applications, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of TI products in such safety-critical applications, notwithstanding any applications-related information or support that may be provided by TI. Further, Buyers must fully indemnify TI and its representatives against any damages arising out of the use of TI products in such safety-critical applications.

TI products are neither designed nor intended for use in military/aerospace applications or environments unless the TI products are specifically designated by TI as military-grade or "enhanced plastic." Only products designated by TI as military-grade meet military specifications. Buyers acknowledge and agree that any such use of TI products which TI has not designated as military-grade is solely at the Buyer's risk, and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI products are neither designed nor intended for use in automotive applications or environments unless the specific TI products are designated by TI as compliant with ISO/TS 16949 requirements. Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, TI will not be responsible for any failure to meet such requirements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

Products		Applications	
Audio	www.ti.com/audio	Communications and Telecom	www.ti.com/communications
Amplifiers	amplifier.ti.com	Computers and Peripherals	www.ti.com/computers
Data Converters	dataconverter.ti.com	Consumer Electronics	www.ti.com/consumer-apps
DLP® Products	www.dlp.com	Energy and Lighting	www.ti.com/energy
DSP	dsp.ti.com	Industrial	www.ti.com/industrial
Clocks and Timers	www.ti.com/clocks	Medical	www.ti.com/medical
Interface	interface.ti.com	Security	www.ti.com/security
Logic	logic.ti.com	Space, Avionics and Defense	www.ti.com/space-avionics-defense
Power Mgmt	power.ti.com	Transportation and Automotive	www.ti.com/automotive
Microcontrollers	microcontroller.ti.com	Video and Imaging	www.ti.com/video
RFID	www.ti-rfid.com		
OMAP Mobile Processors	www.ti.com/omap		
Wireless Connectivity	www.ti.com/wirelessconnectivity		

**TI E2E Community Home Page** 

e2e.ti.com

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2011, Texas Instruments Incorporated